Imaging of 5f densities of states in resonant photoemission measurements

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Medium-resolution spectra ($\Delta E = 0.25$ eV) at the 5f Fano resonance in uranium intermetallics are compared to spectra above and below the resonance region to show that the $5f$ (and 6d) spectral weight obtained from resonant photoemission (RP) compares well to the 5f spectral weight obtained at other photon energies. In well-hybridized systems, the $5f$ signal from RP gives an excellent representation of the 5f density of states (DOS). In narrow-band and localized systems, a satellite may appear in addition to 5f DOS-like structure, indicative of correlation effects.

I. INTRODUCTION

A recent publication¹ (SHCZ) has questioned the accuracy of deducing ⁵f bandwidths in uranium intermetallic compounds from resonant photoemission (RP) measurements. They propose that a resonant Auger transition at RP broadens experimental widths. This is indeed an important question owing to the jnterest in this information stimulated by heavy-fermion systems.^{2,3} Understanding the systematics of $5f$ bandwidths may yield insight into heavy-fermion behavior.

RP is understood as an atomic process as first described by Fano⁵ to explain line shapes in core absorption edges. At an excitation threshold, a strong additional channel opens up for 5f emission which interferes with the normal photoemission channel. In the case of uranium, the excitation is a 5d transition at $hv=94$ eV. 5d electrons are pumped into empty 5f states just above E_F where they are trapped in the angular momentum barrier.⁶ As they decay back to refill the 5d hole, they selectively emit another 5f electron from a filled state via a super-Coster-Kronig (SCK) autoionization process. Clearly, other processes are also possible, although with lower probability, including (1) the emission of a 6d electron,⁷ or Coster-Kronig (CK) autoionization and (2) a resonant Auger process⁸⁻¹⁰ whereby the 5d hole is filled by a valence $5f$ electron accompanied by the emission of another valence ⁵f electron. This latter process (which is pinned at E_F) has been suggested by SHCZ to preclude the use of RP to observe Sf character. It differs from SCK (which presumably reflects the ⁵f directly) in that the line shape is a self-convolution of the valence band (i.e., twice as broad). Analyses of RP experiments¹¹ have assumed that the latter process is negligible. In this paper we will show that this is indeed the case.

Parenthetically, why the SCK process works as well as it does for bandlike $5f$ systems to selectively pick out $5f$ (and some 6d} emission is a question that still requires further theoretical investigation. Our present observations regarding RP in uranium compounds directly contradict SHCZ who claim that in well-hybridized 5f systems a resonant Auger channel does accompany the other channels of decay and may account for up to 50% of the spectral weight. The resulting corollary that the $5f$ photocurrent from RP does not image the ⁵f density of states (DOS) in well-hybridized ⁵f bands would be so significant that this assertion requires careful scrutiny. We believe it is differences in resolution, coupled with difficulties in properly normalizing the off-resonance and on-resonance spectra (particularly in $USi₃$) that form the basis for the difference in interpretation. Here it will be demonstrated that RP is indeed a useful tool.

We have utilized RP measurements extensively since we have been interested in accurately measuring the electronic structure of 5f systems.¹³⁻¹⁶ In this paper we report studies on a number of materials at photon energies ranging from 40 to 124 eV, completely spanning the RP region (92–108 eV). This includes several systems (UGe₃, UBe₁₃, USi₃) discussed by SHCZ. It is observed that in systems where the ligand signal is not too strong $(UGe₃,$ USi₃, UBe₁₃), the 5f photocurrent obtained with RP completely matches that obtained at lower energies (e.g., 40 eV). However, while the spectra at 40 eV and at RP are quite similar (indicating they reveal similar information) it is a very separate issue whether they necessarily image the $5f$ DOS. We find that in well-hybridized $5f$ systems (USi₃, UGe₃, URh₃, UIr₃) the match between calculated ⁵f DOS and photoemission is excellent. In nearly localized (UBe_{13}, UPt_3) and localized cases $(UPd_{3-x}Pt_x)$, we believe an additional satellite is evi-

denced, $16 - 17$ the origin of which is still to be fully deter mined. However, our purpose here is to demonstrate that RP is indeed reflecting the direct structure unclouded by the Auger mechanism proposed by SHCZ.

II. EXPERIMENT

Measurements on UBe_{13} were carried out at the Tantalus synchrotron in Stoughton, Wisconsin using a Grasshopper monochromator, while the remaining measurements were done on the U2 beamline at the NSLS in Brookhaven using an ERG monochromator. The UBe_{13} measurements were done at low temperatures (20 K) so that the true instrument resolution can be directly deduced from the sharpness of the Fermi edge.¹⁸ For the remaining measurements, which were performed at room temperature, one must account for kT broadening. In all cases, our instrument resolution determined from the Fermi edge was never worse than 0.3 eV. Samples were prepared in the usual manner by arc-melting the constituents, annealing the resulting buttons, and characterizing the samples by powder-diffraction measurements to verify single phase. They were cleaved in situ to expose a clean surface. The resonant part of the spectrum was obtained by subtracting the spectrum at antiresonance (92 eV) from that at resonance (99 or 108 eV). Before subtracting spectra, it was found useful to first subtract out the secondary background. This was done in the usual manner by assuming that the background at each binding energy is proportional to the total integrated signal at lower binding energies.¹⁹ This has a slight but noticeable effect on the Sf bandwidth. Failure to thus account for background can in some cases result in improper normalization and hence $5f$ bandwidths that are too large.

III. RESULTS AND DISCUSSION

As examples of well-hybridized $5f$ systems, Figs. 1(a) and 1(b) show raw data for UGe₃ (at $hv=63$, 99, and 124 eV) and USi₃ (at $hv=40$ and 108 eV). These materials are actually ideal compounds for analysis because both the germanium and silicon s-p-like emission is extremely weak at and above $h v=40$ eV. Thus, even at energies far from resonance, the photocurrent is primarily due to U 5f and 6d emission. This enables direct comparison of spectra at different $h\nu$. The analysis of UGe₃ is discussed first since SHCZ also conclude that there is no evidence for an Auger broadening in UGe_3 . (They choose to class it as a more localized system. This is not valid as it is certainly better hybridized than the heavy-fermion material UBe_{13} and almost as much so as $USi₃$ discusse below. The Fermi surface of $UGe₃$ has been completely determined¹³ via the de Haas-van Alphen effect. The effective mass $m^* \leq 4$ for all orbits, which is even smaller than in URh₃.) In Fig. 1(a) the RP difference curve (a) is seen to represent well the 5f (strong peak at E_F) and 6d (tailing out to ≈ -5 eV) emission for UGe₃. The width of the 5f derived peak appears to be ≈ 0.85 eV in the raw data but is reduced to ≈ 0.7 eV in the difference curve. This narrowing is primarily a consequence of removal of the background. All widths shown are substantially smaller than previously observed²⁰ value of 1.9 eV, and are a consequence of improved resolution. Except for minor differences possibly attributable to minor changes in surface cleanliness between sweeps (a small amount of $UO₂$ formation will add intensity at -1.5 eV) and relative d- versus f-electron cross section, all spectra are essentially identical. A self-convolution of the Sf bandwidth could produce an Auger feature \approx 2–4 eV wide (possibly 8 eV wide if we include 6d electrons) so the similarity of these data implies that the Auger channel must be very weak.

The raw USi₃ spectra are slightly broader [≈ 0.9 eV full width at half maximum (FWHM)] than the $UGe₃$ spectra as should be expected from the slightly stronger hybridization. On the other band, they are considerably narrower than previous x-ray photoemission spectroscopy (XPS) results,²¹ again reflecting improved resolution Note that the 40-eV spectrum is essentially identical to the 108-eV spectrum with only minor differences emphasized by the difference curve. Both spectra are also

FIG. 1. (a) Photoemission spectra for UGe_3 with background removed. The difference curve a (resonance minus antiresonance) is nearly identical to the direct spectra (curve b , 63 eV; curve c, 99 eV; curve d, 124 eV) because the Ge p emission is so weak. (b) Comparison of the photoemission spectra for $USi₃$ at 40 and 108 eV.

similar to the previous XPS data once differences in resolution are accounted for. The XPS data have previously been shown to be consistent²² with a calculated bandstructure DOS. Consequently, the RP data must be consistent with band calculations as well. An RP subtracted curve is not shown for $USi₃$ because of difficulties encountered in establishing the normalization. A strong silicon Auger peak at ≈ 88 eV kinetic energy appears in the resonance region.²³ Failure to subtract it out prior to analyzing the Sf data will result in erroneous 5f widths. The raw $UGe₃$ and $USi₃$ data are so similar, however, that one must believe that the subtracted spectra would also be similar albeit slightly broader for $USi₃$ (perhaps 0.9 eV at FWHM). While not shown, the data for the extremely well-hybridized 5f compounds URh_3 and UIr_3 likewise exhibit agreemen '⁴ between the observed $5f$ photos pectrum and the Sf DOS. The evidence is thus quite strong that any Auger contribution is extremely weak in the well-hybridized materials.

Possibly, there is a slight hint of extra intensity for both UGe₃ and USi₃ in the -1 to -2 eV range in the on-resonance spectra [shown by the difference curve in Fig. 1(b)]. Because it is so weak one should be cautious in attributing it to a resonant Auger feature. It could be accounted for by differences in either cross section or resolution between the two photon energies. In any case, there is a similar suggestion of extra intensity in the XPS spectra, $2^{1,22}$ where the Auger feature is not in question.

Because the interpretation of RP depends on the subtraction of data, one must be very careful about the normalization of data. It is a mistake to normalize at a sharp peak when comparing data of different resolutions. Since the ⁵f band density is ^a very sharp structure in the above spectra, the effect of instrument resolution will be quite profound. Poorer resolution will primarily result in a diminution of the sharp peak intensity at E_F . In this case, normalization at the secondary background is much better if the samples are clean. Figure 2 demonstrates the effect of resolution by superimposing the present USi_3 data ($\Delta E = 0.25$ eV) on data¹ with $\Delta E \approx 1.0$ eV. The spectra are normalized on the background. Clearly, the measured FWHM is a strong function of resolution.

We next examine UBe_{13} which is a heavy-fermion material and thus should be classed as a nearly localized or at least a weakly hybridized material² — certainly not as a well-hybridized material.¹ It too is a material well suited for analysis since previous measurements^{24,25} have shown that the beryllium p emission is also quite weak compared to the uranium $5f$ or 6d emission. Figure 3 compares a theoretical curve²⁶ (solid line) and two experiment curves. The dashed curve is the RP difference curve using the 99-eV resonance, and the dotted curve is the raw 40-eV spectrum (taken at 20 K) but with the background subtracted out. The spectra were normalized at -1 eV. For the sake of clarification, the 40-eV spectrum is actually a composite of two spectra at different resolutions. Below -1.0 eV (where no sharp features are observed) the dotted 40-eV spectrum was taken with $\Delta E = 0.3$ eV to emulate the resolution existing at $h\nu=99$ eV, and it is then joined to a spectrum taken with 0.09 eV resolution¹⁸ above -1 eV. The reason for this is that with $\Delta E = 0.3$

FIG. 2. Comparison of USi₃ spectrum having $\Delta E = 0.25$ eV (dotted curve) with one having $\Delta E = 1.0$ eV at the 108-eV resonance (from Ref. 1). Spectra were normalized on the secondary tail since differences in resolution are too great to allow normalization at the sharp peak. The differences in the spectra can be accounted for by differences in resolution.

eV, the very sharp peak at E_F is completely washed out even at $h\nu=40$ eV. The 99-eV RP data and the 40-eV data are seen to differ mainly by the effects of resolution. Data obtained²⁷ for $hv=108$ eV (not shown) are nearly identical to, and possibly even very slightly narrower than, the 99-eV data. Hence, again the evidence is for no sign of an additional Auger broadening appearing at reso nance. Especially in UBe $_{13}$, it is essential to avoid normalization at the very sharp peak at E_F when comparing data of different resolution.

The two experimental UBe_{13} curves in Fig. 3 are obviously substantially broader than the theoretical curve.

FIG. 3. Photoemission spectra for UBe_{13} compared to a broadened theoretical DOS. Dashed curve is the RP difference curve $(5f$ and $6d$ emission) and dotted curve is a composite spectrum for $h v=40$ eV with background subtracted. The sharp peak at E_F is unobservable for a resolution $\Delta E \approx 0.3$ eV (see text).

The theoretical curve, constructed by convoluting the partial densities of states with the respective transition probabilities and further convoluting with instrumental broading (a Gaussian of 0.8 eV width), is the direct band-structure result. Much of the apparent large width of the experimental 5f DOS in UBe₁₃ is then actually a consequence of U 6d emission. There is still, however, extra intensity observed in the $-1-eV$ region as a consequence of correlation. Allen et $al.^{28}$ were first to point out this correlation intensity in $UAI₂$ and $UPt₃$. While they saw it only as a tailing of $5f$ spectral weight to higher binding energies, we have suggested^{16,17} it to be a due to a well-defined 5f satellite centered at ≈ -1 eV, which would appear with increasing intensity as the $5f$ states become more localized. Subsequently, the extra intensity has been noted by others.^{29,30} The spectra then consist of ^a blurred image of the ⁵f DOS admixed with ^a weaker image of the 6d DOS plus this additional satellite. This proposed satellite structure is observed at all photon energies, however, and hence cannot be an Auger feature.

Finally, we consider the localized system $UPd_{3-x}Pt_x$. Neutron diffraction data, 31 coupled with the specific-heation data, 32 clearly demonstrate the localized nature of 5f electrons in UPd₃. Baer et al.³³ have demonstrated that the photoemission fingerprint for localized 5f behavior in UPd₃ is the lack of 5f intensity at E_F . This fingerprint is observed for almost the entire range of x (up to $x = 2.6$). The arguments of SHCZ suggest that there should be no resonant Auger transition for localized systems. Yet the data for the UPd_{3-x}Pt_x system show evidence for additional (satellite) intensity at 1.5 eV. The spectra in Fig. 4 are difference spectra (99—92 and 124—92 eV) for the $x = 0.025$ sample. Note that they are again very similar. The feature at -6 eV is a resonant feature (not related to any Auger transition) possibly due to 6d emission. It is not the satellite discussed above. In compounds where the ligand atoms (Pd and Pt) contribute substantial d spectral weight, resonating U 6d intensity is often normalized out (i.e., it usually mimics the ligand d DOS). but that does not appear to be happening here. The feature is, in any case, not directly related to the current question. This alloy system is particularly useful because at $UPd_{1.5}Pt_{1.5}$ a double peak structure is clearly distinguish able without requiring careful data manipulation. The entire series has been extensively studied and will be reported in full elsewhere. 34 Based on analysis of that data, we may note here that the "localized $5f$ peak" in Fig. 4, apparently centered at ≈ -1 eV, is actually composed of a main peak centered at ≈ -0.6 eV and a satellite centered at ≈ -1.1 eV. This produces the large width and the asymmetric line shape tailing off to higher binding en-

FIG. 4. 5f intensities (for the $x = 0.025$ sample) obtained by subtracting the spectrum for $h v=92$ eV from spectra for $hv=99$ and 124 eV. Data were normalized on a d peak at ≈ -4 eV. The 5f spectral weights obtained at the two photon energies are identical, indicating no resonant Auger peaks.

ergy. This structure again appears for all photon energies and should not be ascribed to an Auger process. Nonetheless, contrary to the analysis of SHCZ a broadening or actual additional peak is observed in these localized systems although the source is different from that discussed by SHCZ.

In conclusion we reiterate that the $5f$ line shape obtained at resonance in uranium compounds accurately matches the 5f lineshape obtained for photon energies away from resonance. There is, at best, weak evidence for a resonant Auger channel having measurable strength in any system that we studied. Some of the reported broadening in RP experiments (versus higher or lower $h\nu$) may be simply due to instrument broadening, combined with an improper subtraction of the background. Whether the line shapes image the 5f DOS is a separate question. That imaging appears to be quite good in wellhybridized ⁵f systems but not in very-narrow-band systems. In any case, one can always pick out the ⁵f-6d portion of the photocurrent by doing a resonance experiment with the exception that the 6d DOS is often subtracted out in compounds with transition metals.

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